

Notice of References Cited

Application/Control No.

10/553,556

Applicant(s)/Patent Under
Reexamination
STESSEN ET AL.

Examiner

PAULOS M. NATNAEL

Art Unit

2622

Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------------|----------------|
| * | A | US-7,170,880 | 01-2007 | Webster et al. | 370/338 |
| * | B | US-6,662,367 | 12-2003 | Dapper et al. | 725/105 |
| * | C | US-5,848,097 | 12-1998 | Carney et al. | 375/219 |
| * | D | US-6,281,873 | 08-2001 | Oakley, David | 345/418 |
| * | E | US-6,347,123 | 02-2002 | Mathe et al. | 375/324 |
| * | F | US-6,956,617 | 10-2005 | Demmer, Walter Heinrich | 348/441 |
| * | G | US-6,546,407 | 04-2003 | Jiang et al. | 708/313 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.